3.3V, Crystal to 100MHz/ 200MHz Quad HCSL/LVDS **Clock Generator**

The NB3N51034 is a high precision, low phase noise clock generator that supports spread spectrum designed for PCI Express applications. This device takes a 25 MHz fundamental mode parallel resonant crystal and generates 4 differential HCSL/LVDS outputs at 100 MHz or 200 MHz (See Figure 6 for LVDS interface). The NB3N51034 provides selectable spread options of -0.5%, -1.0%, -1.5%, for applications demanding low Electromagnetic Interference (EMI). No spread setting is also available.

Features

- Uses 25 MHz Fundamental Mode Parallel Resonant Crystal
- Power Down Mode
- 4 Low Skew HCSL or LVDS Outputs
- OE Tri-States Outputs
- Spread of -0.5%, -1.0%, -1.5% and No Spread
- PCIe Gen 1, 2, 3 Jitter Compliant
- Phase Noise (SS OFF) @ 100 MHz:

Noise Power Offset 100 Hz -110 dBc/Hz 1 kHz -123 dBc/Hz 10 kHz $-134 \, dBc/Hz$ -137 dBc/Hz 100 kHz 1 MHz -138 dBc/Hz 10 MHz $-154 \, dBc/Hz$

- Operating Range 3.3 V ±5%
- Industrial Temperature Range –40°C to +85°C
- Functionally Compatible with IDT557-05, IDT5V41066, IDT5V41236
- These are Pb-Free Devices

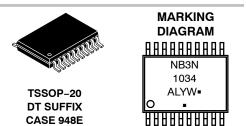
Applications

- Networking
- Consumer



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= Assembly Location

= Wafer Lot = Year W = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

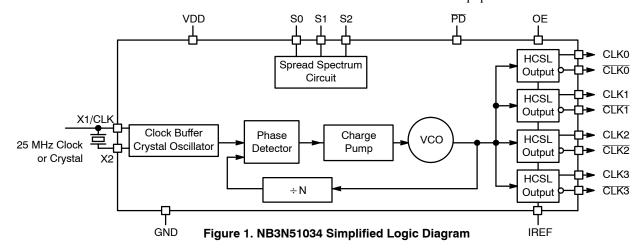
ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

- Computing and Peripherals
- Industrial Equipment
- PCIe Clock Generation Gen I, Gen II and Gen III

End Products

- Switch and Router
- Set Top Box, LCD TV
- Servers, Desktop Computers
- Automated Test Equipment



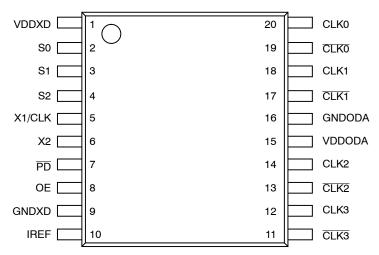


Figure 2. Pin Configuration (Top View)

Table 1. PIN DESCRIPTION

Pin	Symbol	I/O	Description
1	VDDXD	Power	Connect to a +3.3 V source.
2	S0	Input	Spread Spectrum Select pin 0. See Spread Spectrum Select table. Internal pull-up resistor.
3	S1	Input	Spread Spectrum Select pin 1. See Spread Spectrum Select table. Internal pull-up resistor.
4	S2	Input	Spread Spectrum Select pin 2. See Spread Spectrum Select table. Internal pull-up resistor.
5	X1/CLK	Input	Crystal interface or single-ended reference clock input.
6	X2	Output	Crystal interface. Float this pin for reference clock input CLK.
7	PD	Input	Power down. Internal pull-up resistor.
8	OE	Input	Output enable. Tri-state output (High=enable outputs, Low=disable outputs). Internal pull-up resistor.
9	GNDXD	Power	Connect to digital circuit ground.
10	I _{REF}	Output	Precision resistor attached to this pin is connected to the internal current reference.
11	CLK3	Output	Selectable 100/200 MHz Spread Spectrum differential compliment output clock 3.
12	CLK3	Output	Selectable 100/200 MHz Spread Spectrum differential true output clock 3.
13	CLK2	Output	Selectable 100/200 MHz Spread Spectrum differential compliment output clock 2.
14	CLK2	Output	Selectable 100/200 MHz Spread Spectrum differential true output clock 2.
15	VDDODA	Power	Connect to a +3.3 V analog source.
16	GNDODA	Power	Output and analog circuit ground.
17	CLK1	Output	Selectable 100/200 MHz Spread Spectrum differential compliment output clock 1.
18	CLK1	Output	Selectable 100/200 MHz Spread Spectrum differential true output clock 1.
19	CLK0	Output	Selectable 100/200 MHz Spread Spectrum differential compliment output clock 0.
20	CLK0	Output	Selectable 100/200 MHz Spread Spectrum differential true output clock 0.

Table 2. OUTPUT FREQUENCY AND SPREAD SPECTRUM SELECT TABLE

S2	S1	S0	Spread%	Spread Type	Output Frequency
0	0	0	-0.5	Down	100
0	0	1	-1.0	Down	100
0	1	0	-1.5	Down	100
0	1	1	No Spread	N/A	100
1	0	0	-0.5	Down	200
1	0	1	-1.0	Down	200
1	1	0	-1.5	Down	200
1	1	1	No Spread	N/A	200

Recommended Crystal Parameters

Crystal Frequency Load Capacitance Shunt Capacitance, C0 Equivalent Series Resistance Initial Accuracy at 25 °C	Fundamental AT–Cut 25 MHz 16–20 pF 7 pF Max 50 Ω Max ±20 ppm
•	

Table 3. ATTRIBUTES

Characteris	Value					
Internal Input Default State Resistor (110 kΩ					
ESD Protection	2 kV					
Moisture Sensitivity, Indefinite Time O	Moisture Sensitivity, Indefinite Time Out of Dray Pack (Note 1)					
Flammability Rating	UL 94 V-0 @ 0.125 in					
Transistor Count	132,000					
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test						

^{1.} For additional information, see Application Note AND8003/D.

Table 4. MAXIMUM RATINGS (Note 2)

Symbol	Parameter	Condition 1	Condition 2	Rating	Units
V_{DD}	Positive Power Supply	GND = 0 V		4.6	V
VI	Input Voltage (V _{IN})	GND = 0 V	$GND \leq V_I \leq V_{DD}$	-0.5 V to V _{DD} +0.5 V	٧
T _A	Operating Temperature Range			-40 to +85	°C
T _{stg}	Storage Temperature Range			-65 to +150	°C
θ_{JA}	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	TSSOP-20 TSSOP-20	140 50	°C/W °C/W
$\theta_{\sf JC}$	Thermal Resistance (Junction-to-Case)	(Note 3)	TSSOP-20	23 to 41	°C/W
T _{sol}	Wave Solder			265	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Table 5. DC CHARACTERISTICS (V_{DD} = 3.3 V $\pm 5\%$, GND = 0 V, T_A = -40°C to +85°C, Note 4)

Symbol	Characteristic	Min	Тур	Max	Unit
VDD	Power Supply Voltage	3.135	3.3	3.465	V
I _{DD}	Power Supply Current, 200 Mhz output, SSON		135		mA
I _{DDOE}	Power Supply Current when OE is Set Low		60		mA
I _{DDPD}	Power Supply Current (PD = Low, no load)		1.5		mA
V _{IH}	Input HIGH Voltage (X1/CLK, S0, S1, S2 and OE)	2000		V _{DD} + 300	mV
V_{IL}	Input LOW Voltage (X1/CLK, S0, S1, S2 and OE)	GND - 300		800	mV

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

4. Measurement taken with outputs terminated with R_S = 33.2 Ω , R_L = 50 Ω , with test load capacitance of 2 pF and current biasing resistor set at 475 Ω . See Figure 5. Guaranteed by characterization.

^{2.} Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and not valid simultaneously. If stress limits are exceeded device functional operation is not implied, damage may occur and reliability may be affected.

^{3.} JEDEC standard multilayer board – 2S2P (2 signal, 2 power).

Table 6. AC CHARACTERISTICS ($V_{DD} = 3.3 \text{ V} \pm 5\%$, GND = 0 V, $T_A = -40^{\circ}\text{C}$ to +85°C; Note 5)

Symbol	Characteristic	Min	Тур	Max	Unit
f _{CLKIN}	Clock/Crystal Input Frequency		25		MHz
f _{CLKOUT}	Output Clock Frequency		100/200		MHz
Vmax	Absolute Maximum Output Voltage (Notes 6, 7)			1150	mV
Vmin	Absolute Minimum Output Voltage (Notes 6, 8)	-300			mV
Vrb	Ringback Voltage (Notes 9, 10)	-100		100	mV
VOH	Output High Voltage (Note 6)	660		850	mV
VOL	Output Low Voltage (Note 6)	-150		27	mV
V _{CROSS}	Absolute Crossing Voltage (Notes 6, 10, 11)	250		550	mV
ΔV_{CROSS}	Total Variation of V _{CROSS} (Notes 6, 10, 12)			140	mV
f _{MOD}	Spread Spectrum Modulation Frequency	30	31.5	33.33	kHz
SSC _{RED}	Spectral Reduction (Note 13), 3 rd harmonic		-10		dB
t _{SKEW}	Within Device Output to Output Skew			40	ps
ΦNOISE	Phase-Noise Performance SS OFF f _{CLKout} = 100 MHz				dBc/Hz
	@ 100 Hz offset from carrier		-110		7
	@ 1 kHz offset from carrier		-123		7
	@ 10 kHz offset from carrier		-134		7
	@ 100 kHz offset from carrier		-137		7
	@ 1 MHz offset from carrier		-138		7
	@ 10 MHz offset from carrier		-154		7
t _{OE}	Output Enable/Disable Time (All outputs) (Note 14)			10	μs
t _{DUTY_CYCLE}	Output Clock Duty Cycle (Measured at cross point)	45	50	55	%
t _R	Output Risetime (Measured from 175 mV to 525 mV, Figure 7)	175	340	700	ps
t _F	Output Falltime (Measured from 525 mV to 175 mV, Figure 7)	175	400	700	ps
Δt_{R}	Output Risetime Variation (Single-Ended)			125	ps
Δt_{F}	Output Falltime Variation (Single-Ended)			125	ps
Stabilization Time	Stabilization Time From Powerup $V_{DD} = 3.3 \text{ V}$		3.0		ms

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 5. Measurement taken from differential output on single–ended channel terminated with $R_S = 33.2 \,\Omega$, $R_L = 50 \,\Omega$, with test load capacitance of 2 pF and current biasing resistor set at 475 Ω . See Figure 5. Guaranteed by characterization.
- 6. Measurement taken from single-ended waveform
- 7. Defined as the maximum instantaneous voltage value including positive overshoot
- 8. Defined as the maximum instantaneous voltage value including negative overshoot
- 9. Measurement taken from differential waveform
- 10. Measured at crossing point where the instantaneous voltage value of the rising edge of CLKx+ equals the falling edge of CLKx-.
- 11. Refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing. Refers to all crossing points for this measurement.
- 12. Defined as the total variation of all crossing voltage of rising CLKx+ and falling CLKx-. This is maximum allowed variance in the VCROSS for any particular system.
- 13. Spread spectrum clocking enabled.
- 14. Output pins are tri-stated when OE is asserted LOW. Output pins are driven differentially when OE is HIGH unless device is in power down mode, PD = Low.

Table 7. AC ELECTRICAL CHARACTERISTICS - PCI EXPRESS JITTER SPECIFICATIONS,

 V_{DD} = 3.3 V \pm 5%, T_A = $-40^{\circ}C$ to 85°C

Symbol	Parameter	Test Conditions		Min	Тур	Max	PCIe Industry Spec	Unit
tj (PCle Gen 1)	Phase Jitter Peak-to-Peak	f = 100 MHz, 25 MHz Crystal Input Evaluation Band:	SSOFF		10	20	86	ps
	(Notes 16 and 19)	0 Hz – Nyquist (clock frequency/2)	SSON (-0.5%)		19	28		
tREFCLK_HF_RMS (PCle Gen 2)	Phase Jitter	f = 100 MHz, 25 MHz Crystal	SSOFF		1.0	1.8	3.1	ps
(Pole Gell 2)	RMS (Notes 17 and 19)	Input High Band: 1.5 MHz – Nyquist (clock frequency/2)	SSON (-0.5%)		1.1	1.9		
tREFCLK_LF_RMS	Phase Jitter	f = 100 MHz, 25 MHz Crystal	SSOFF		0.1	0.15	3.0	ps
(PCle Gen 2)	RMS (Notes 17 and 19)	Input Low Band: 10 kHz – 1.5 MHz	SSON (-0.5%)		0.8	1.1		
tREFCLK_RMS	Phase Jitter	f = 100 MHz, 25 MHz Crystal	SSOFF		0.35	0.7	1.0	ps
(PCIe Gen 3)	RMS (Notes 18 and 19)	Input Evaluation Band: 0 Hz – Nyquist (clock frequency/2)	SSON (-0.5%)		0.55	0.8		

^{15.} Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

^{16.} Peak-to-Peak jitter after applying system transfer function for the Common Clock Architecture. Maximum limit for PCI Express Gen 1 is 86 ps peak-to-peak for a sample size of 106 clock periods.

^{17.} RMS jitter after applying the two evaluation bands to the two transfer functions defined in the Common Clock Architecture and reporting the worst case results for each evaluation band. Maximum limit for PCI Express Generation 2 is 3.1 ps RMS for tREFCLK_HF_RMS (High Band) and 3.0ps RMS for tREFCLK LF RMS (Low Band).

^{18.} RMS jitter after applying system transfer function for the common clock architecture.

^{19.} Measurement taken from differential output on single–ended channel terminated with $R_S = 33.2 \Omega$, $R_L = 50 \Omega$, with test load capacitance of 2 pF and current biasing resistor set at 475 Ω . See Figure 5. This parameter is guaranteed by characterization. Not tested in production.

PHASE NOISE

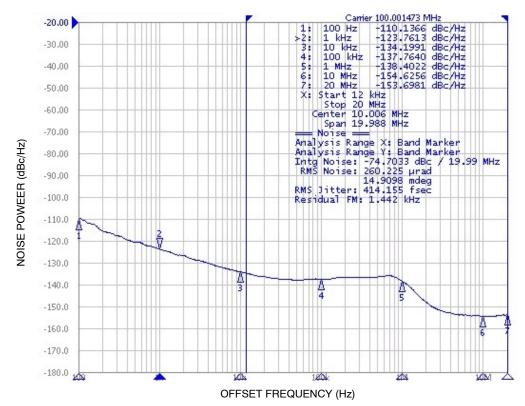


Figure 3. Typical Phase Noise at 100 MHz; integration range 12 kHz to 20 MHz (Input source at 25 MHz and HCSL output termination)

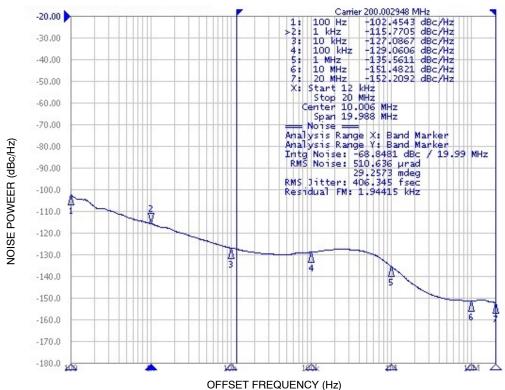


Figure 4. Typical Phase Noise at 200 MHz; integration range 12 kHz to 20 MHz (Input source at 25 MHz and HCSL output termination)

HCSL INTERFACE

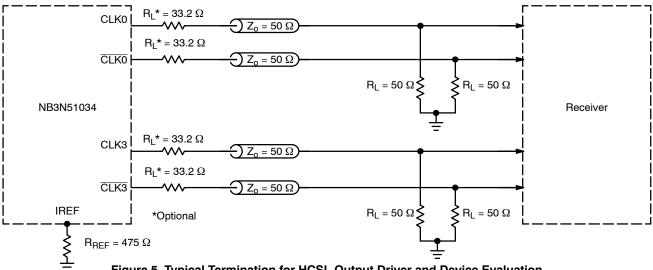


Figure 5. Typical Termination for HCSL Output Driver and Device Evaluation

LVDS COMPATIBLE INTERFACE

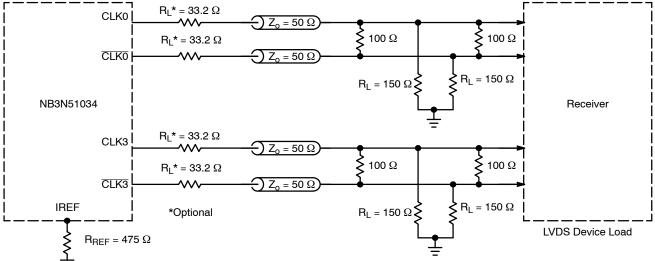


Figure 6. Typical Termination for LVDS Device Load

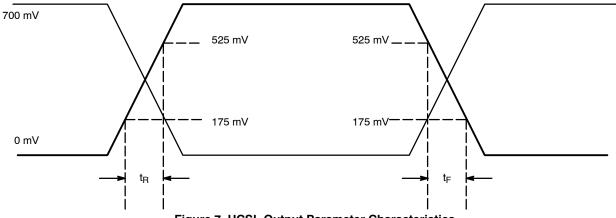


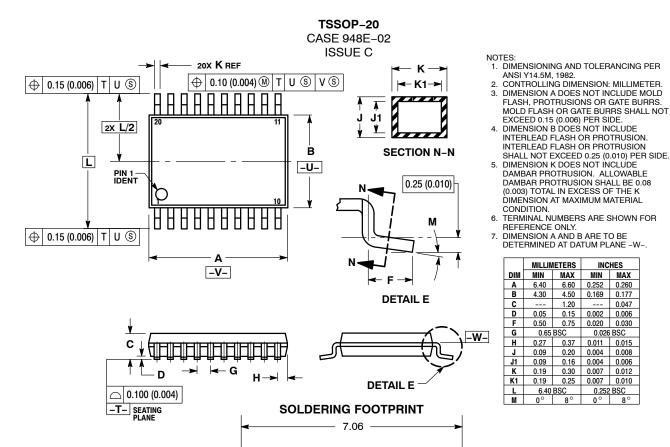
Figure 7. HCSL Output Parameter Characteristics

ORDERING INFORMATION

Device	Package	Shipping [†]
NB3N51034DTG	TSSOP-20 (Pb-Free)	75 Units / Rail
NB3N51034DTR2G	TSSOP-20 (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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